Welcome!







Prof. dr. Gert Rietveld EMN SEG chair gert.rietveld@vsl.nl

Some housekeeping



- The meeting will be recorded to facilitate summarizing the discussion outcomes
 - Only the presentations will be made public, so feel free to comment!

- Please turn your cameras on...
- but mute your microphone when you are not speaking
- Use the 'raise hand' function if you want to ask a question
- Use the chat to give comments, ask questions and raise issues

Smart Grid measurement challenges



3 discussion sessions each with a slight specific focus

16 November, 10 am CET
 DC grids and HV testing

25 November, 10 am CET Digital transformation and cybersecurity

■ 1st December, 10 am CET Measurement of grid signals

Feel free to register to all sessions!

Agenda



Time (CET)	Item
10:00	Welcome
10:05	Measurement needs identified via a recent stakeholder survey
10.15	Keynote on DC grid challenges by Dr Mathieu Caujolle, Électricité de France (EDF)
10.35	Forum discussion on metrology needs for DC grids, HV testing and other smart grid measurement challenges
11.45	Wrap up
12:00	End of the meeting





Strategic Research Agenda Stakeholder Survey

SMART ELECTRICITY GRIDS

Dr Marc-Olivier André marc-olivier.andre@metas.ch

EUROPEAN METROLOGY NETWORKS



Strategic Research Agenda



EMN SEG Strategic Research Agenda

Draft version 1.0 (11/2020) For approval BoD

Guiding future R&D along stakeholder needs

 1st draft prepared based on existing knowledge of stakeholder needs

DRAFT

European Metrology Network Smart Electricity Grids

Feedback loop including stakeholders

Strategic Research Agenda

<u>Link to Strategic Research Agenda >></u>

9 Themes of the SRA









Revenue Metering **Power Quality**

Grid Monitoring & Data Analytics

Digital Substations









Instrument
Transformers
and Sensors

High-Voltage Testing Efficiency

DC Grids and Applications

and "Grid Integration"

Measurement challenges for each SRA theme





Digital Substations

4.4 Digital substations

Future electrical power grids will require real-time control and monitoring systems to meet increasingly complex and challenging conditions. Digital instrumentation will slowly substitute conventional analogue instrumentation. New standards in the IEC 61869 series address the digital communication of electronic instrument transformers, as well as standalone merging units (SAMUs) and digitisers for analogue instrument transformers. Following the introduction of these new standards, the transition from traditional analogue instrumentation towards the new digital instrumentation technology is expected to gain speed, both on a transmission and distribution level. To support this change, new metrological tools and methodologies are needed as test systems for new technology.

level of IT security to prevent malevolent coordinated intrusions from destabilising the grid control.

4.4.1 Some measurement challenges in digital instrumentation

- New metrological tools and methodologies for intelligent electronic devices (electronic instrument transformers, SAMU, all-digital meters and PMUs)
- Investigation of PTP or White Rabbit methods for accurate time-stamps
- Addressing IT security of smart meters at the proper level



Stakeholder survey



 Stakeholders asked about the relevance of specific measurement challenges for the 9 themes

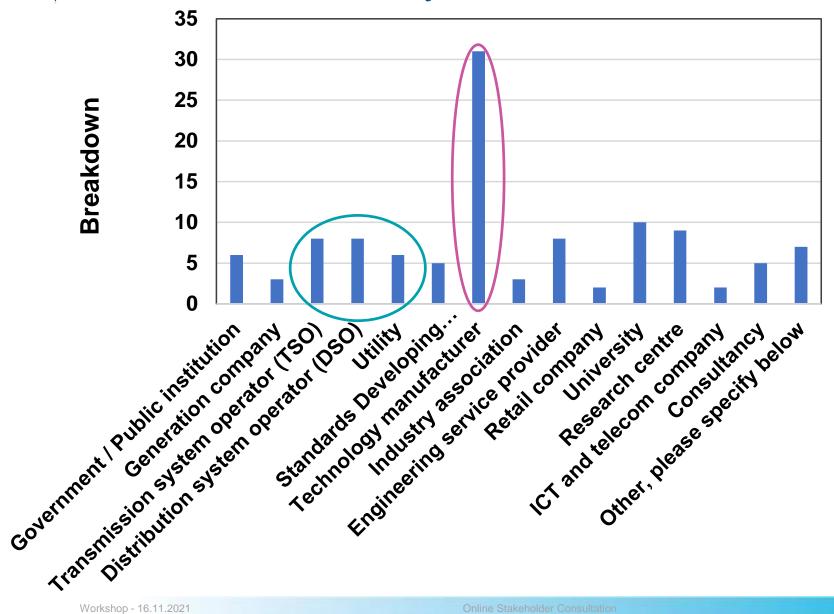
Took place during March – April 2021



80 participants from 18 countries across European continent

Stakeholder survey





40 % from Technology manufacturer

30 % from Utilities & Network **Operators**

60 % from organisations with > 500 employees

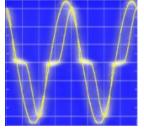
Top 5 metrological challenges from the survey



1. Fault location identification



- 2. Full characterisation of the frequency transfer function of instrument transformers
- 3. Monitoring the propagation of transient and disturbance phenomena



- 4. New characterisation methods for instrument transformer with PQ phenomena
- New metrological tools and methodologies for intelligent electronic devices



DC Grids – Top 3 metrological challenges



- 1. On-site measurement data for proper sets of DC PQ parameter definitions
- 2. Characterisation methods regarding efficiency and state of typical DC applications

3. Specifications and methodologies for PQ "compatibility level" and "planning

level" in LVDC







High-voltage testing – Top 3 metrological challenges



1. Non-destructive testing techniques for commissioning or preventive maintenance

Findings of the survey

- 2. Traceability for voltage dividers and measuring systems for composite and combined wave shapes
- 3. Loss measurements of power transformers, and high voltage capacitors and reactors



Keynote address



DC grid challenges

Dr. Mathieu CAUJOLLE

Team manager – Grid Planning, Protection and Power Quality

Electricité de France

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